

| Application No. | Applicant(s) |
|-------------------|-----------------|
| 09/647,650 | ESCAFFRE ET AL. |
| Examiner | Art Unit |
| Edward M. Johnson | 1754 |

| | SEAR | CHED | Examiner | | |
|-------|----------|------|----------|--|--|
| Class | Subclass | Date | Examiner | | |
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| INT | INTERFERENCE SEARCHED | | | |
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| Class | Subclass | Date | Examiner | |
| 502 | 242 | 1/15/2004 | EJ | |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | | |
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| | DATE | EXMR | | |
| Yen Nguyen, particle size | 1/15/2004 | EJ | | |
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